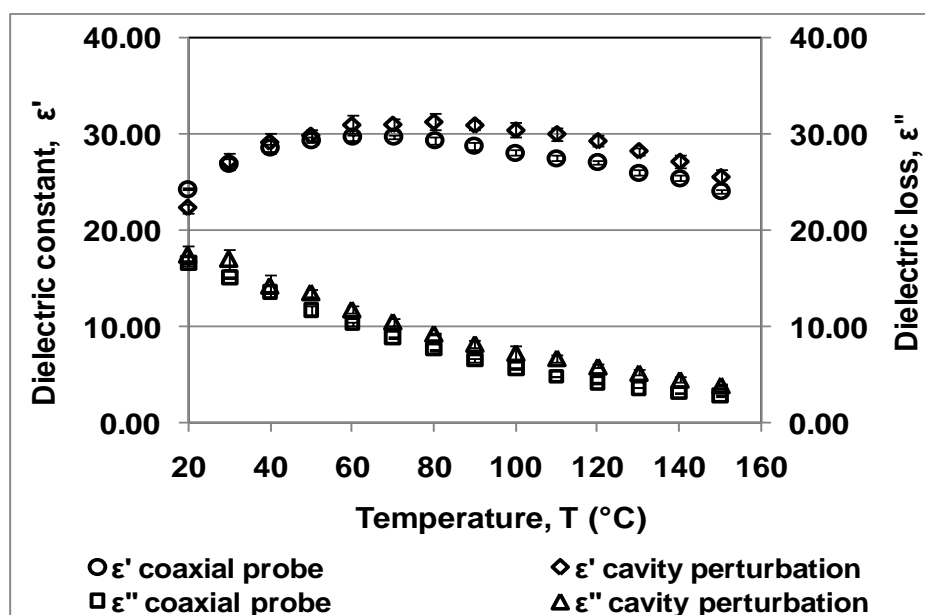


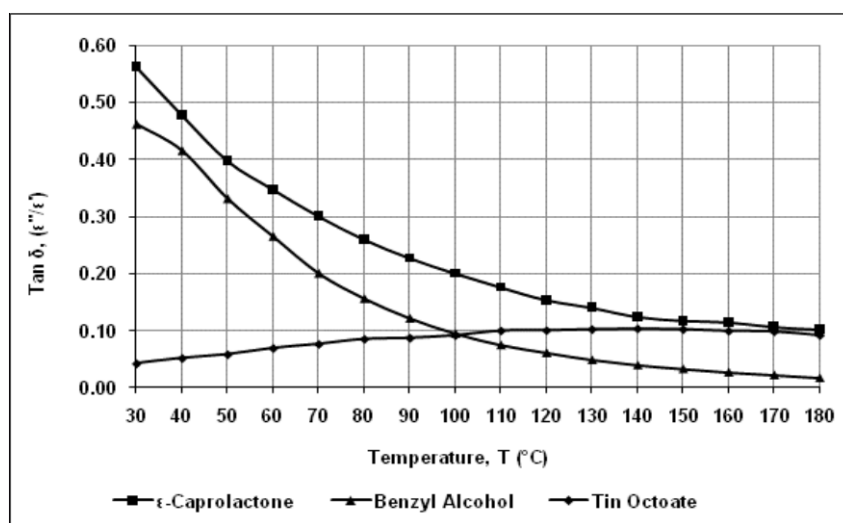
Extra Scientific Information

Continuous and Direct '*In Situ*' Reaction Monitoring of Chemical Reactions *via* Dielectric Property Measurement: Controlled Polymerisation

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ESI Figure 1: Dielectric properties for CL, comparison between results produced by coaxial probe and cavity perturbation techniques.



ESI Figure 1: 2 - Variation in the Loss tangent of PCL precursors at 2470 MHz versus temperature

